

ISL9V2540S3S

EcoSPARK™ N-Channel Ignition IGBT

250mJ, 400V

Features

- SCIS Energy = 250mJ at $T_J = 25^\circ\text{C}$
- Logic Level Gate Drive

Applications

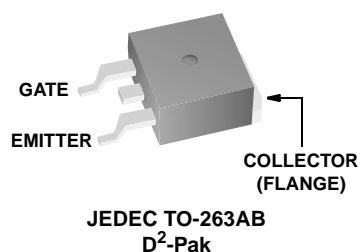
- Automotive Ignition Coil Driver Circuits
- Coil - On Plug Applications

General Description

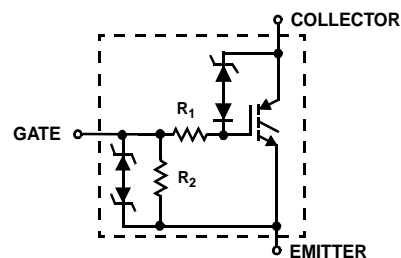
The ISL9V2540S3S is a next generation ignition IGBT that offers outstanding SCIS capability in the industry standard D²-Pak (TO-263) plastic package. This device is intended for use in automotive ignition circuits, specifically as a coil driver. Internal diodes provide voltage clamping without the need for external components.

EcoSPARK™ devices can be custom made to specific clamp voltages. Contact your nearest Fairchild sales office for more information.

Package



Symbol



Device Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
BV_{CER}	Collector to Emitter Breakdown Voltage ($I_C = 1 \text{ mA}$)	430	V
BV_{ECS}	Emitter to Collector Voltage - Reverse Battery Condition ($I_C = 10 \text{ mA}$)	24	V
$E_{\text{SCIS}25}$	At Starting $T_J = 25^\circ\text{C}$, $I_{\text{SCIS}} = 12.9\text{A}$, $L = 3.0\text{mH}$	250	mJ
$E_{\text{SCIS}150}$	At Starting $T_J = 150^\circ\text{C}$, $I_{\text{SCIS}} = 10\text{A}$, $L = 3.0\text{mH}$	150	mJ
$I_{\text{C}25}$	Collector Current Continuous, At $T_C = 25^\circ\text{C}$, See Fig 9	15.5	A
$I_{\text{C}110}$	Collector Current Continuous, At $T_C = 110^\circ\text{C}$, See Fig 9	15.3	A
V_{GEM}	Gate to Emitter Voltage Continuous	± 10	V
P_D	Power Dissipation Total $T_C = 25^\circ\text{C}$	166.7	W
	Power Dissipation Derating $T_C > 25^\circ\text{C}$	1.11	W/ $^\circ\text{C}$
T_J	Operating Junction Temperature Range	-40 to 175	$^\circ\text{C}$
T_{STG}	Storage Junction Temperature Range	-40 to 175	$^\circ\text{C}$
T_L	Max Lead Temp for Soldering (Leads at 1.6mm from Case for 10s)	300	$^\circ\text{C}$
T_{pkg}	Max Lead Temp for Soldering (Package Body for 10s)	260	$^\circ\text{C}$
ESD	Electrostatic Discharge Voltage at 100pF, 1500 Ω (HBM)	4	kV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
V2540S	ISL9V2540S3ST	TO-263AB	330mm	24mm	800 units
V2540S	ISL9V2540S3S	TO-263AB	Tube	N/A	50 units

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off State Characteristics

BV_{CER}	Collector to Emitter Breakdown Voltage	$I_C = 2\text{mA}$, $V_{\text{GE}} = 0$, $R_G = 1\text{K}\Omega$, See Fig. 15 $T_J = -40$ to 150°C	370	400	430	V
BV_{CES}	Collector to Emitter Breakdown Voltage	$I_C = 10\text{mA}$, $V_{\text{GE}} = 0$, $R_G = 0$, See Fig. 15 $T_J = -40$ to 150°C	390	420	450	V
BV_{ECS}	Emitter to Collector Breakdown Voltage	$I_C = -75\text{mA}$, $V_{\text{GE}} = 0\text{V}$, $T_C = 25^\circ\text{C}$	30	-	-	V
BV_{GES}	Gate to Emitter Breakdown Voltage	$I_{\text{GES}} = \pm 2\text{mA}$	± 12	± 14	-	V
I_{CER}	Collector to Emitter Leakage Current	$V_{\text{CER}} = 250\text{V}$, $R_G = 1\text{K}\Omega$, See Fig. 11	$T_C = 25^\circ\text{C}$	-	-	25 μA
			$T_C = 150^\circ\text{C}$	-	-	1 mA
I_{ECS}	Emitter to Collector Leakage Current	$V_{\text{EC}} = 24\text{V}$, See Fig. 11	$T_C = 25^\circ\text{C}$	-	-	1 mA
			$T_C = 150^\circ\text{C}$	-	-	40 mA
R_1	Series Gate Resistance		-	70	-	Ω
R_2	Gate to Emitter Resistance		10K	-	26K	Ω

On State Characteristics

$V_{\text{CE(SAT)}}$	Collector to Emitter Saturation Voltage	$I_C = 6\text{A}$, $V_{\text{GE}} = 4\text{V}$	$T_C = 25^\circ\text{C}$, See Fig. 3	-	1.37	1.8	V
$V_{\text{CE(SAT)}}$	Collector to Emitter Saturation Voltage	$I_C = 10\text{A}$, $V_{\text{GE}} = 4.5\text{V}$	$T_C = 150^\circ\text{C}$ See Fig. 4	-	1.77	2.2	V

Dynamic Characteristics

Q _{G(ON)}	Gate Charge	I _C = 10A, V _{CE} = 12V, V _{GE} = 5V, See Fig. 14		-	15.1	-	nC
V _{GE(TH)}	Gate to Emitter Threshold Voltage	I _C = 1.0mA, V _{CE} = V _{GE} , See Fig. 10	T _C = 25°C	1.3	-	2.2	V
			T _C = 150°C	0.75	-	1.8	V
V _{GEP}	Gate to Emitter Plateau Voltage	I _C = 10A, V _{CE} = 12V		-	3.1	-	V

Switching Characteristics

$t_{d(ON)R}$	Current Turn-On Delay Time-Resistive	$V_{CE} = 14V$, $R_L = 1\Omega$ $V_{GE} = 5V$, $R_G = 1K\Omega$ $T_J = 25^\circ C$	-	0.61	-	μs
t_{riseR}	Current Rise Time-Resistive		-	2.17	-	μs
$t_{d(OFF)L}$	Current Turn-Off Delay Time-Inductive	$V_{CE} = 300V$, $L = 500\mu Hy$, $V_{GE} = 5V$, $R_G = 1K\Omega$ $T_J = 25^\circ C$, See Fig. 12	-	3.64	-	μs
t_{fL}	Current Fall Time-Inductive		-	2.36	-	μs
SCIS	Self Clamped Inductive Switching	$T_J = 25^\circ C$, $L = 3.0mHy$, $R_G = 1K\Omega$, $V_{GE} = 5V$, See Fig. 1 & 2	-	-	250	mJ

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance Junction-Case	TO-263	-	-	0.9	$^\circ C/W$
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Typical Performance Curves

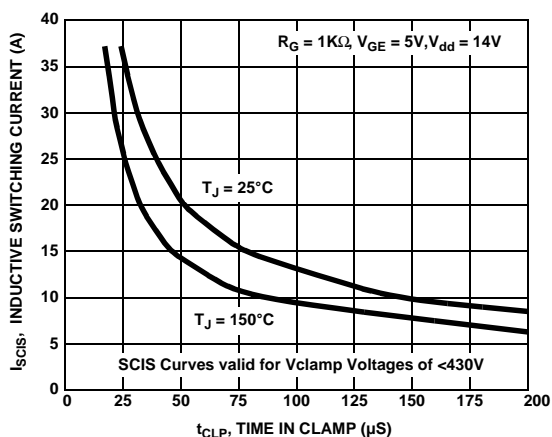


Figure 1. Self Clamped Inductive Switching Current vs Time in Clamp

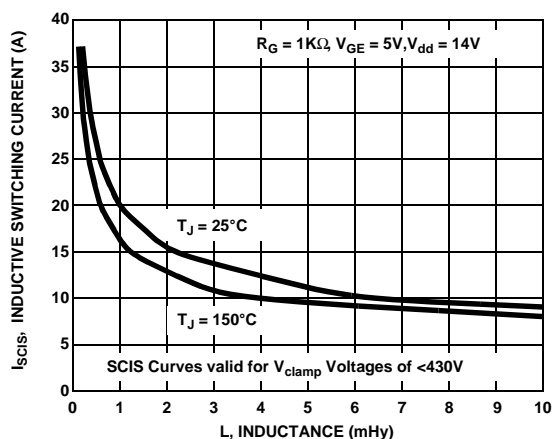


Figure 2. Self Clamped Inductive Switching Current vs Inductance

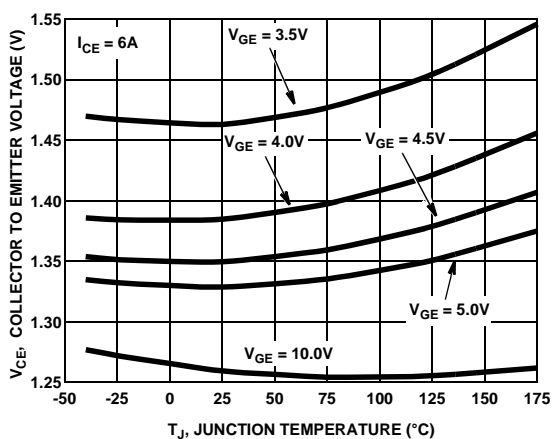


Figure 3. Collector to Emitter On-State Voltage vs Junction Temperature

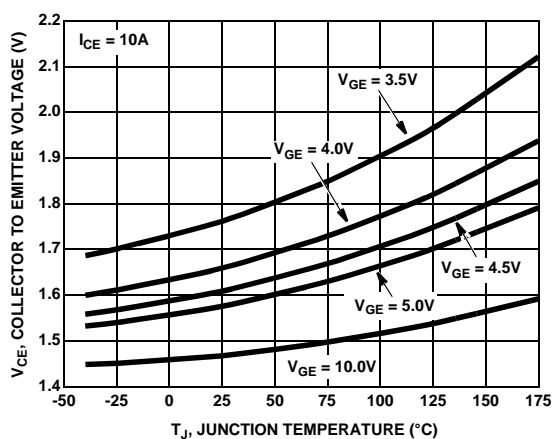


Figure 4. Collector to Emitter On-State Voltage vs Junction Temperature

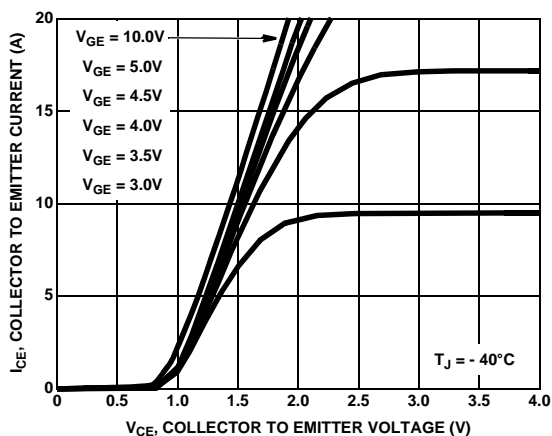


Figure 5. Collector to Emitter On-State Voltage vs Collector Current

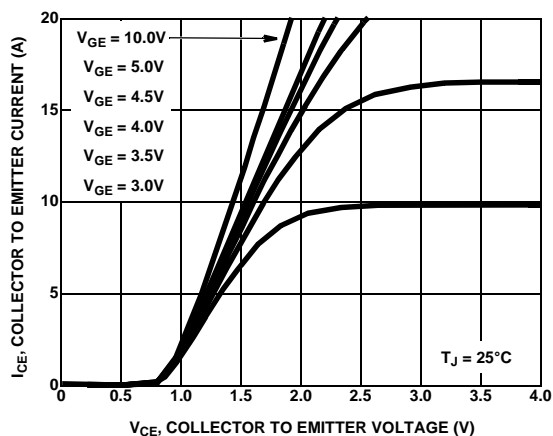


Figure 6. Collector to Emitter On-State Voltage vs Collector Current

Typical Performance Curves (Continued)

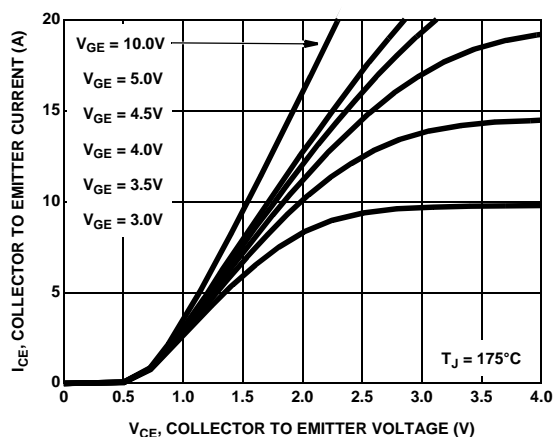


Figure 7. Collector to Emitter On-State Voltage vs Collector Current

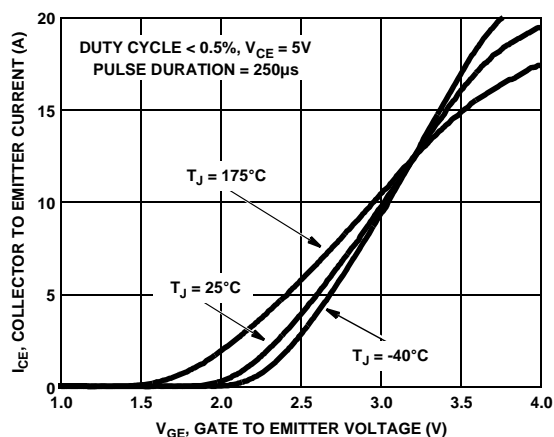


Figure 8. Transfer Characteristics

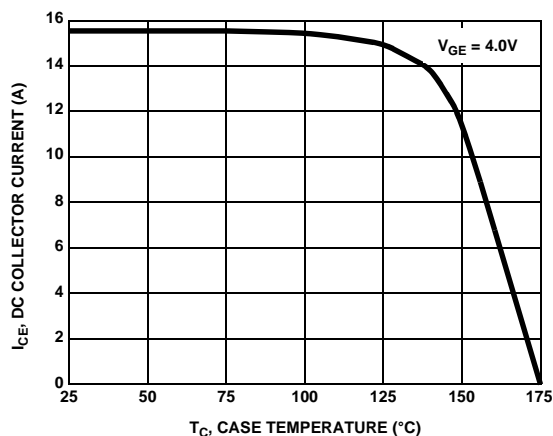


Figure 9. DC Collector Current vs Case Temperature

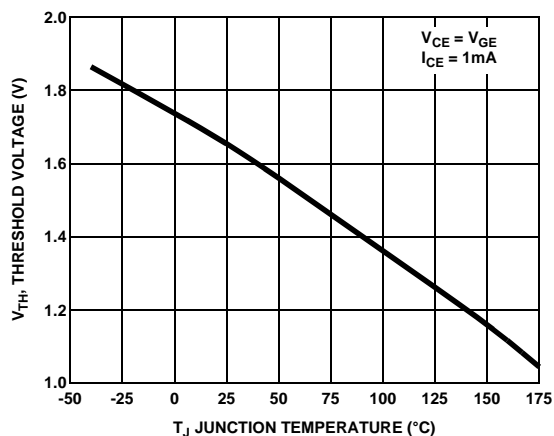


Figure 10. Threshold Voltage vs Junction Temperature

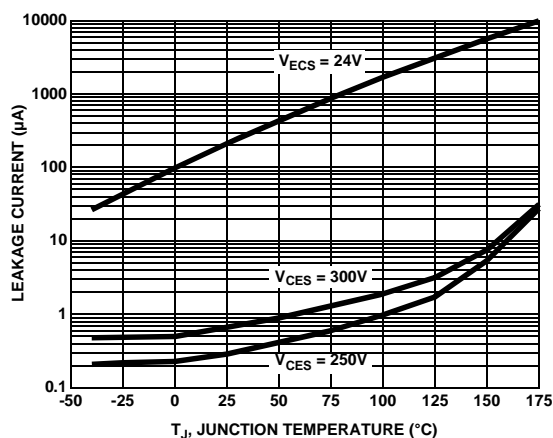


Figure 11. Leakage Current vs Junction Temperature

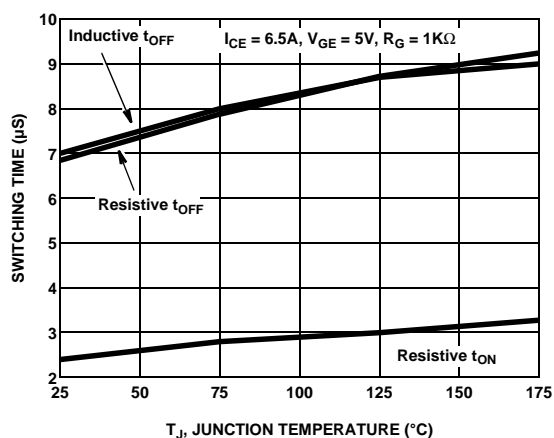


Figure 12. Switching Time vs Junction Temperature

Typical Performance Curves (Continued)

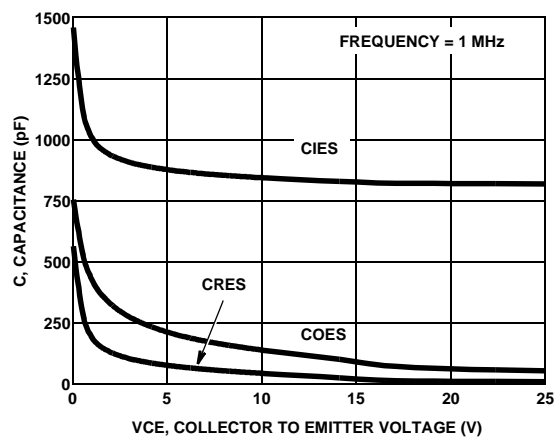


Figure 13. Capacitance vs Collector to Emitter Voltage

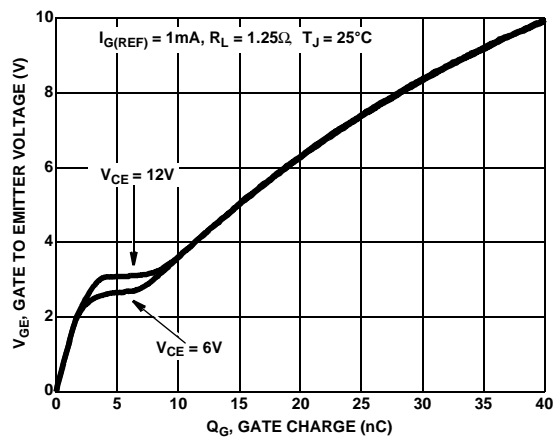


Figure 14. Gate Charge

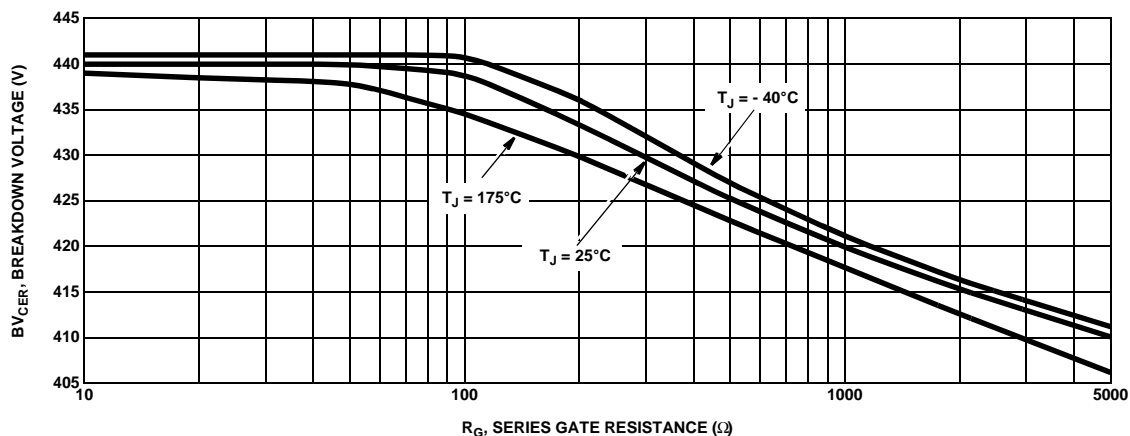


Figure 15. Breakdown Voltage vs Series Gate Resistance

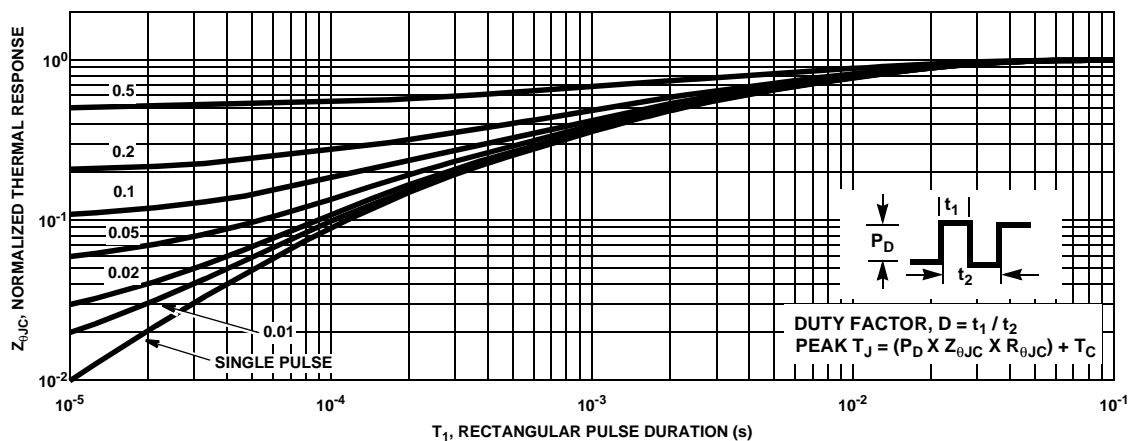


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

Test Circuit and Waveforms

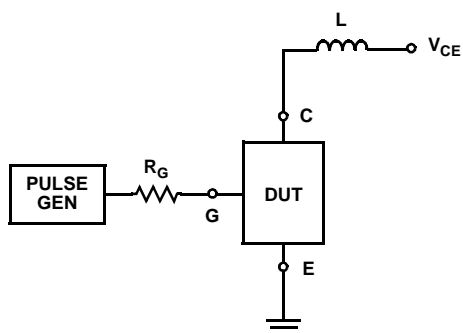


Figure 17. Inductive Switching Test Circuit

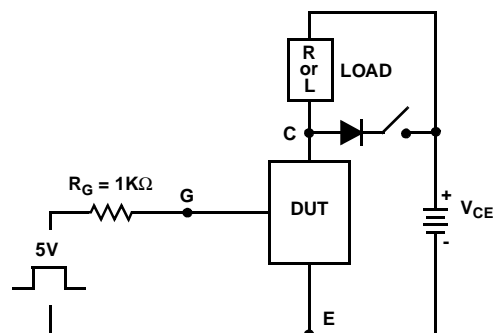


Figure 18. t_{ON} and t_{OFF} Switching Test Circuit

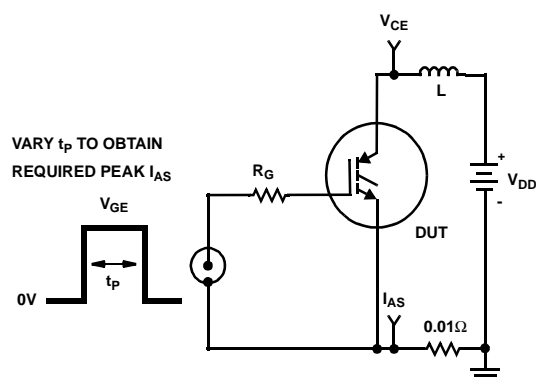


Figure 19. Unclamped Energy Test Circuit

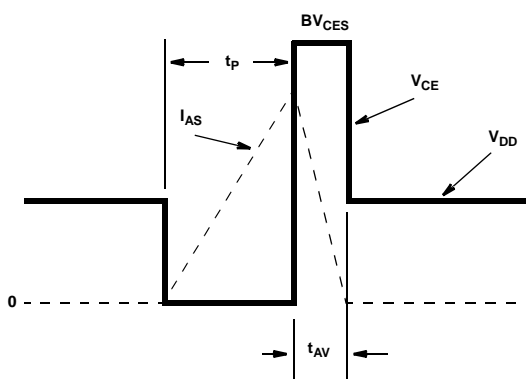


Figure 20. Unclamped Energy Waveforms

SPICE Thermal Model

REV 16 May 2005

ISL9V2540S3S

CTHERM1 th 6 19e -4

CTHERM2 6 5 12e -3

CTHERM3 5 4 15e -3

CTHERM4 4 3 25e -3

CTHERM5 3 2 69e -3

CTHERM6 2 tl 100e -3

RTHERM1 th 6 80e -3

RTHERM2 6 5 81e -3

RTHERM3 5 4 82e -3

RTHERM4 4 3 100e -3

RTHERM5 3 2 150e -3

RTHERM6 2 tl 1645e -4

SABER Thermal Model

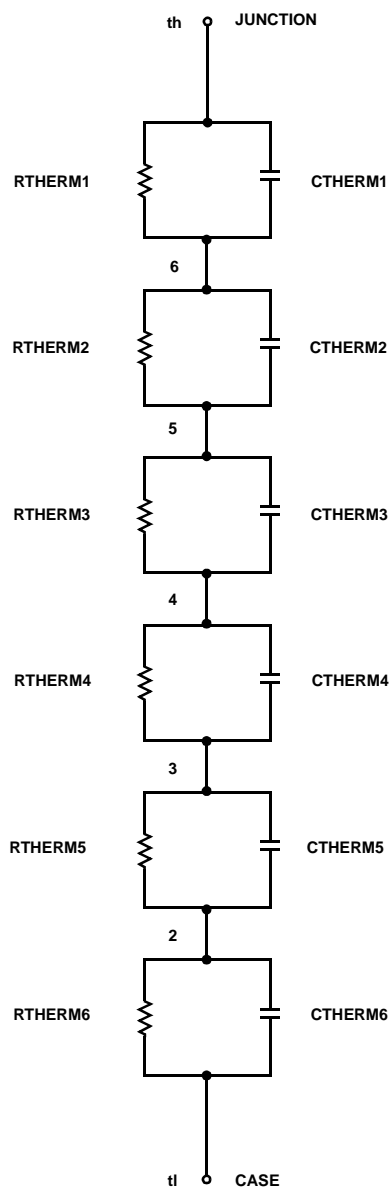
ISL9V2540S3S

template thermal_model th tl

thermal_c th, tl

```
{
  ctherm.ctherm1 th 6 = 19e -4
  ctherm.ctherm2 6 5 = 12e -3
  ctherm.ctherm3 5 4 = 15e -3
  ctherm.ctherm4 4 3 = 25e -3
  ctherm.ctherm5 3 2 = 69e -3
  ctherm.ctherm6 2 tl = 100e -3
```

```
  rtherm.rtherm1 th 6 = 80e -3
  rtherm.rtherm2 6 5 = 81e -3
  rtherm.rtherm3 5 4 = 82e -3
  rtherm.rtherm4 4 3 = 100e -3
  rtherm.rtherm5 3 2 = 150e -3
  rtherm.rtherm6 2 tl = 1645e -4
}
```



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Build it Now™	FRFET™	MicroFET™	QS™	TINYOPTO™
CoolFET™	GlobalOptoisolator™	MicroPak™	QT Optoelectronics™	TruTranslation™
CROSSVOLT™	GTO™	MICROWIRE™	Quiet Series™	UHC™
DOME™	HiSeC™	MSX™	RapidConfigure™	UltraFET®
EcoSPARK™	I ² C™	MSXPro™	RapidConnect™	UniFET™
E ² C MOS™	i-Lo™	OCX™	µSerDes™	VCX™
EnSigna™	ImpliedDisconnect™	OCXPro™	SILENT SWITCHER®	Wire™
FACT™	IntelliMAX™	OPTOLOGIC®	SMART START™	
FACT Quiet Series™		OPTOPLANAR™	SPM™	
Across the board. Around the world.™		PACMAN™	Stealth™	
The Power Franchise®		POP™	SuperFET™	
Programmable Active Droop™		Power247™	SuperSOT™-3	
		PowerEdge™	SuperSOT™-6	

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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